

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In Re PATENT APPLICATION of:

Robert L. FRANCH et al.

Appln. No: 10/824,297

Filed: APRIL 14, 2004

For: ON CHIP TEMPERATURE MEASURING  
AND MONITORING CIRCUIT  
AND METHOD

Art Unit: 2859

Examiner: Gail VERBITSKY

**AMENDMENT AFTER FINAL**

Mail Stop **AF**  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir,

Responsive to a final Office action dated January 3, 2007, the applicants request amendment of the above identified application as follows:

**Amendments to the Claims** begin on page 2 of this amendment.

**Remarks** begin on page 8 of this amendment.